Application-Motivated Combinations of Fuzzy, Interval, and Probability Approaches, with Application to Geoinformatics, Bioinformatics, and Engineering

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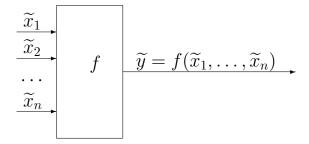
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Interval computations website: http://www.cs.utep.edu/interval-comp



1. General Problem of Data Processing under Uncertainty

- *Indirect measurements:* way to measure y that are are difficult (or even impossible) to measure directly.
- *Idea*: $y = f(x_1, ..., x_n)$



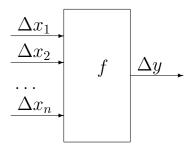
• Problem: measurements are never 100% accurate: $\widetilde{x}_i \neq x_i \ (\Delta x_i \neq 0)$ hence

$$\widetilde{y} = f(\widetilde{x}_1, \dots, \widetilde{x}_n) \neq y = f(x_1, \dots, x_n).$$

What are bounds on $\Delta y \stackrel{\text{def}}{=} \widetilde{y} - y$?



2. Probabilistic and Interval Uncertainty

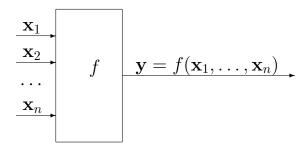


- Traditional approach: we know probability distribution for Δx_i (usually Gaussian).
- Where it comes from: calibration using standard MI.
- *Problem:* calibration is not possible in:
 - fundamental science
 - manufacturing
- Solution: we know upper bounds Δ_i on $|\Delta x_i|$ hence

$$x_i \in [\widetilde{x}_i - \Delta_i, \widetilde{x}_i + \Delta_i].$$



3. Interval Computations: A Problem



- Given: an algorithm $y = f(x_1, ..., x_n)$ and n intervals $\mathbf{x}_i = [\underline{x}_i, \overline{x}_i]$.
- Compute: the corresponding range of y: $[y, \overline{y}] = \{ f(x_1, \dots, x_n) \mid x_1 \in [\underline{x}_1, \overline{x}_1], \dots, x_n \in [\underline{x}_n, \overline{x}_n] \}.$
- Fact: NP-hard even for quadratic f.
- Challenge: when are feasible algorithm possible?
- Challenge: when computing $\mathbf{y} = [\underline{y}, \overline{y}]$ is not feasible, find a good approximation $\mathbf{Y} \supseteq \mathbf{y}$.



4. Alternative Approach: Maximum Entropy

- Situation: in many practical applications, it is very difficult to come up with the probabilities.
- Traditional engineering approach: use probabilistic techniques.
- *Problem:* many different probability distributions are consistent with the same observations.
- Solution: select one of these distributions e.g., the one with the largest entropy.
- Example single variable: if all we know is that $x \in [\underline{x}, \overline{x}]$, then MaxEnt leads to a uniform distribution on $[\underline{x}, \overline{x}]$.
- Example multiple variables: different variables are independently distributed.



5. Limitations of Maximum Entropy Approach

- Example: simplest algorithm $y = x_1 + \ldots + x_n$.
- Measurement errors: $\Delta x_i \in [-\Delta, \Delta]$.
- Analysis: $\Delta y = \Delta x_1 + \ldots + \Delta x_n$.
- Worst case situation: $\Delta y = n \cdot \Delta$.
- Maximum Entropy approach: due to Central Limit Theorem, Δy is \approx normal, with $\sigma = \Delta \cdot \frac{\sqrt{n}}{\sqrt{3}}$.
- Why this may be inadequate: we get $\Delta \sim \sqrt{n}$, but due to correlation, it is possible that $\Delta = n \cdot \Delta \sim n \gg \sqrt{n}$.
- Conclusion: using a single distribution can be very misleading, especially if we want guaranteed results.
- Examples: high-risk application areas such as space exploration or nuclear engineering.



6. Interval Arithmetic: Foundations of Interval Techniques

• *Problem:* compute the range

$$[\underline{y}, \overline{y}] = \{ f(x_1, \dots, x_n) \mid x_1 \in [\underline{x}_1, \overline{x}_1], \dots, x_n \in [\underline{x}_n, \overline{x}_n] \}.$$

- Interval arithmetic: for arithmetic operations $f(x_1, x_2)$ (and for elementary functions), we have explicit formulas for the range.
- Examples: when $x_1 \in \mathbf{x}_1 = [\underline{x}_1, \overline{x}_1]$ and $x_2 \in \mathbf{x}_2 = [\underline{x}_2, \overline{x}_2]$, then:
 - The range $\mathbf{x}_1 + \mathbf{x}_2$ for $x_1 + x_2$ is $[\underline{x}_1 + \underline{x}_2, \overline{x}_1 + \overline{x}_2]$.
 - The range $\mathbf{x}_1 \mathbf{x}_2$ for $x_1 x_2$ is $[\underline{x}_1 \overline{x}_2, \overline{x}_1 \underline{x}_2]$.
 - The range $\mathbf{x}_1 \cdot \mathbf{x}_2$ for $x_1 \cdot x_2$ is $[y, \overline{y}]$, where

$$\underline{y} = \min(\underline{x}_1 \cdot \underline{x}_2, \underline{x}_1 \cdot \overline{x}_2, \overline{x}_1 \cdot \underline{x}_2, \overline{x}_1 \cdot \overline{x}_2);
\overline{y} = \max(\underline{x}_1 \cdot \underline{x}_2, \underline{x}_1 \cdot \overline{x}_2, \overline{x}_1 \cdot \underline{x}_2, \overline{x}_1 \cdot \overline{x}_2).$$

• The range $1/\mathbf{x}_1$ for $1/x_1$ is $[1/\overline{x}_1, 1/\underline{x}_1]$ (if $0 \notin \mathbf{x}_1$).

General Problem of ... Probabilistic and . . . Case Study: Chip Design Combining Interval... Case Study: . . . General Problem Case Study: Detecting . . Fuzzy Computations: . . . Acknowledgments Title Page Page 7 of 35 Go Back Full Screen

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7. Straightforward Interval Computations: Example

- Example: $f(x) = (x-2) \cdot (x+2), x \in [1,2].$
- How will the computer compute it?
 - $\bullet r_1 := x 2;$
 - \bullet $r_2 := x + 2;$
 - $\bullet \ r_3 := r_1 \cdot r_2.$
- Main idea: perform the same operations, but with intervals instead of numbers:
 - $\mathbf{r}_1 := [1, 2] [2, 2] = [-1, 0];$
 - $\mathbf{r}_2 := [1, 2] + [2, 2] = [3, 4];$
 - $\mathbf{r}_3 := [-1, 0] \cdot [3, 4] = [-4, 0].$
- Actual range: $f(\mathbf{x}) = [-3, 0]$.
- Comment: this is just a toy example, there are more efficient ways of computing an enclosure $Y \supseteq y$.



8. Case Study: Chip Design

- Chip design: one of the main objectives is to decrease the clock cycle.
- Current approach: uses worst-case (interval) techniques.
- *Problem:* the probability of the worst-case values is usually very small.
- Result: estimates are over-conservative unnecessary over-design and under-performance of circuits.
- Difficulty: we only have partial information about the corresponding probability distributions.
- Objective: produce estimates valid for all distributions which are consistent with this information.
- What we do: provide such estimates for the clock time.



9. Estimating Clock Cycle: a Practical Problem

- Objective: estimate the clock cycle on the design stage.
- The clock cycle of a chip is constrained by the maximum path delay over all the circuit paths

$$D \stackrel{\text{def}}{=} \max(D_1, \dots, D_N).$$

- The path delay D_i along the *i*-th path is the sum of the delays corresponding to the gates and wires along this path.
- Each of these delays, in turn, depends on several factors such as:
 - the variation caused by the current design practices,
 - environmental design characteristics (e.g., variations in temperature and in supply voltage), etc.



10. Traditional (Interval) Approach to Estimating the Clock Cycle

- Traditional approach: assume that each factor takes the worst possible value.
- Result: time delay when all the factors are at their worst.
- Problem:
 - different factors are usually independent;
 - combination of worst cases is improbable.
- Computational result: current estimates are 30% above the observed clock time.
- Practical result: the clock time is set too high chips are over-designed and under-performing.



11. Robust Statistical Methods Are Needed

- *Ideal case:* we know probability distributions.
- Solution: Monte-Carlo simulations.
- In practice: we only have partial information about the distributions of some of the parameters; usually:
 - the mean, and
 - some characteristic of the deviation from the mean
 - e.g., the interval that is guaranteed to contain possible values of this parameter.
- Possible approach: Monte-Carlo with several possible distributions.
- *Problem:* no guarantee that the result is a valid bound for all possible distributions.
- Objective: provide robust bounds, i.e., bounds that work for all possible distributions.



12. Towards a Mathematical Formulation of the Problem

- General case: each gate delay d depends on the difference x_1, \ldots, x_n between the actual and the nominal values of the parameters.
- Main assumption: these differences are usually small.
- Each path delay D_i is the sum of gate delays.
- Conclusion: D_i is a linear function: $D_i = a_i + \sum_{j=1}^n a_{ij} \cdot x_j$ for some a_i and a_{ij} .
- The desired maximum delay $D = \max_{i} D_{i}$ has the form

$$D = F(x_1, \dots, x_n) \stackrel{\text{def}}{=} \max_i \left(a_i + \sum_{j=1}^n a_{ij} \cdot x_j \right).$$



13. Towards a Mathematical Formulation of the Problem (cont-d)

• *Known:* maxima of linear function are exactly convex functions:

$$F(\alpha \cdot x + (1 - \alpha) \cdot y) \le \alpha \cdot F(x) + (1 - \alpha) \cdot F(y)$$

for all x, y and for all $\alpha \in [0, 1]$;

- We know: factors x_i are independent;
 - we know distribution of some of the factors;
 - for others, we know ranges $[\underline{x}_i, \overline{x}_j]$ and means E_j .
- Given: a convex function $F \geq 0$ and a number $\varepsilon > 0$.
- Objective: find the smallest y_0 s.t. for all possible distributions, we have $y \leq y_0$ with the probability $\geq 1-\varepsilon$.



14. Additional Property: Dependency is Non-Degenerate

- Fact: sometimes, we learn additional information about one of the factors x_j .
- Example: we learn that x_j actually belongs to a proper subinterval of the original interval $[\underline{x}_i, \overline{x}_i]$.
- Consequence: the class \mathcal{P} of possible distributions is replaced with $\mathcal{P}' \subset \mathcal{P}$.
- Result: the new value y'_0 can only decrease: $y'_0 \leq y_0$.
- Fact: if x_j is irrelevant for y, then $y'_0 = y_0$.
- Assumption: irrelevant variables been weeded out.
- Formalization: if we narrow down one of the intervals $[\underline{x}_j, \overline{x}_j]$, the resulting value y_0 decreases: $y'_0 < y_0$.



15. Formulation of the Problem

GIVEN: \bullet n, $k \le n$, $\varepsilon > 0$;

• a convex function $y = F(x_1, \ldots, x_n) \ge 0$;

• n-k cdfs $F_i(x), k+1 \le j \le n$;

• intervals $\mathbf{x}_1, \dots, \mathbf{x}_k$, values E_1, \dots, E_k ,

TAKE: all joint probability distributions on \mathbb{R}^n for which:

• all x_i are independent,

• $x_j \in \mathbf{x}_j$, $E[x_j] = E_j$ for $j \le k$, and

• x_j have distribution $F_j(x)$ for j > k.

FIND: the smallest y_0 s.t. for all such distributions, $F(x_1, \ldots, x_n) \leq y_0$ with probability $\geq 1 - \varepsilon$.

WHEN: the problem is non-degenerate – if we narrow down one of the intervals \mathbf{x}_j , y_0 decreases.



16. Main Result and How We Can Use It

- Result: y_0 is attained when for each j from 1 to k,
 - $x_j = \underline{x}_j$ with probability $\underline{p}_j \stackrel{\text{def}}{=} \frac{\overline{x}_j E_j}{\overline{x}_j \underline{x}_j}$, and
 - $x_j = \overline{x}_j$ with probability $\overline{p}_j \stackrel{\text{def}}{=} \frac{E_j \underline{x}_j}{\overline{x}_j \underline{x}_j}$.
- Algorithm:
 - simulate these distributions for x_i , j < k;
 - simulate known distributions for j > k;
 - use the simulated values $x_i^{(s)}$ to find

$$y^{(s)} = F(x_1^{(s)}, \dots, x_n^{(s)});$$

- sort N values $y^{(s)}$: $y_{(1)} \le y_{(2)} \le \ldots \le y_{(N_i)}$;
- take $y_{(N_i\cdot(1-\varepsilon))}$ as y_0 .



17. Comment about Monte-Carlo Techniques

- Traditional belief: Monte-Carlo methods are inferior to analytical:
 - they are approximate;
 - they require large computation time;
 - simulations for *several* distributions, may mis-calculate the (desired) maximum over *all* distributions.
- We proved: the value corresponding to the selected distributions indeed provide the desired maximum value y_0 .
- General comment:
 - justified Monte-Carlo methods often lead to faster computations than analytical techniques;
 - example: multi-D integration where Monte-Carlo methods were originally invented.



18. Comment about Non-Linear Terms

- Reminder: in the above formula $D_i = a_i + \sum_{j=1}^{n} a_{ij} \cdot x_j$, we ignored quadratic and higher order terms in the dependence of each path time D_i on parameters x_j .
- In reality: we may need to take into account some quadratic terms.
- Idea behind possible solution: it is known that the max $D = \max_{i} D_{i}$ of convex functions D_{i} is convex.
- Condition when this idea works: when each dependence $D_i(x_1, \ldots, x_k, \ldots)$ is still convex.
- Solution: in this case,
 - the function function D is still convex,
 - hence, our algorithm will work.



19. Conclusions

- Problem of chip design: decrease the clock cycle.
- How this problem is solved now: by using worst-case (interval) techniques.
- Limitations of this solution: the probability of the worst-case values is usually very small.
- Consequence: estimates are over-conservative, hence over-design and under-performance of circuits.
- Objective: find the clock time as y_0 s.t. for the actual delay y, we have $\text{Prob}(y > y_0) \le \varepsilon$ for given $\varepsilon > 0$.
- Difficulty: we only have partial information about the corresponding distributions.
- What we have described: a general technique that allows us, in particular, to compute y_0 .



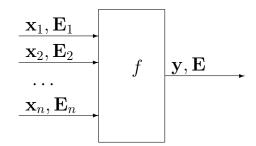
20. Combining Interval and Probabilistic Uncertainty: General Case

- *Problem:* there are many ways to represent a probability distribution.
- *Idea:* look for an objective.
- Objective: make decisions $E_x[u(x,a)] \to \max$.
- Case 1: smooth u(x).
- Analysis: we have $u(x) = u(x_0) + (x x_0) \cdot u'(x_0) + \dots$
- Conclusion: we must know moments to estimate E[u].
- Case of uncertainty: interval bounds on moments.
- Case 2: threshold-type u(x).
- Conclusion: we need cdf $F(x) = \text{Prob}(\xi \leq x)$.
- Case of uncertainty: p-box $[\underline{F}(x), \overline{F}(x)]$.



21. Extension of Interval Arithmetic to Probabilistic Case: Successes

- General solution: parse to elementary operations +, -, \cdot , 1/x, max, min.
- Explicit formulas for arithmetic operations known for intervals, for p-boxes $\mathbf{F}(x) = [\underline{F}(x), \overline{F}(x)]$, for intervals + 1st moments $E_i \stackrel{\text{def}}{=} E[x_i]$:





22. Successes (cont-d)

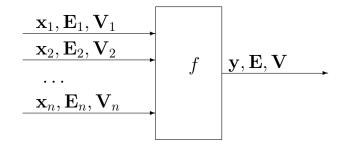
- Easy cases: +, -, product of independent x_i .
- Example of a non-trivial case: multiplication $y = x_1 \cdot x_2$, when we have no information about the correlation:
 - $\underline{E} = \max(p_1 + p_2 1, 0) \cdot \overline{x}_1 \cdot \overline{x}_2 + \min(p_1, 1 p_2) \cdot \overline{x}_1 \cdot \underline{x}_2 + \min(1 p_1, p_2) \cdot \underline{x}_1 \cdot \overline{x}_2 + \max(1 p_1 p_2, 0) \cdot \underline{x}_1 \cdot \underline{x}_2;$
 - $\overline{E} = \min(p_1, p_2) \cdot \overline{x}_1 \cdot \overline{x}_2 + \max(p_1 p_2, 0) \cdot \overline{x}_1 \cdot \underline{x}_2 + \max(p_2 p_1, 0) \cdot \underline{x}_1 \cdot \overline{x}_2 + \min(1 p_1, 1 p_2) \cdot \underline{x}_1 \cdot \underline{x}_2,$

where $p_i \stackrel{\text{def}}{=} (E_i - \underline{x}_i)/(\overline{x}_i - \underline{x}_i)$.

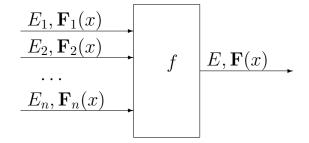


23. Challenges

• intervals + 2nd moments:



• moments + p-boxes; e.g.:





24. Case Study: Bioinformatics

- Practical problem: find genetic difference between cancer cells and healthy cells.
- *Ideal case:* we directly measure concentration c of the gene in cancer cells and h in healthy cells.
- In reality: difficult to separate.
- Solution: we measure $y_i \approx x_i \cdot c + (1 x_i) \cdot h$, where x_i is the percentage of cancer cells in *i*-th sample.
- Equivalent form: $a \cdot x_i + h \approx y_i$, where $a \stackrel{\text{def}}{=} c h$.



25. Case Study: Bioinformatics (cont-d)

• If we know x_i exactly: Least Squares Method C(x,y)

$$\sum_{i=1}^{n} (a \cdot x_i + h - y_i)^2 \to \min_{a,h}, \text{ hence } a = \frac{C(x,y)}{V(x)} \text{ and }$$

$$h = E(y) - a \cdot E(x)$$
, where $E(x) = \frac{1}{n} \cdot \sum_{i=1}^{n} x_i$,

$$V(x) = \frac{1}{n-1} \cdot \sum_{i=1}^{n} (x_i - E(x))^2,$$

$$C(x,y) = \frac{1}{n-1} \cdot \sum_{i=1}^{n} (x_i - E(x)) \cdot (y_i - E(y)).$$

- Interval uncertainty: experts manually count x_i , and only provide interval bounds \mathbf{x}_i , e.g., $x_i \in [0.7, 0.8]$.
- Problem: find the range of a and h corresponding to all possible values $x_i \in [\underline{x}_i, \overline{x}_i]$.

General Problem of...

Probabilistic and . . .

Case Study: Chip Design

Combining Interval . . .

Case Study: . . .

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26. General Problem

- General problem:
 - we know intervals $\mathbf{x}_1 = [\underline{x}_1, \overline{x}_1], \ldots, \mathbf{x}_n = [\underline{x}_n, \overline{x}_n],$
 - compute the range of $E(x) = \frac{1}{n} \sum_{i=1}^{n} x_i$, population

variance
$$V = \frac{1}{n} \sum_{i=1}^{n} (x_i - E(x))^2$$
, etc.

- Difficulty: NP-hard even for variance.
- Known:
 - efficient algorithms for \underline{V} ,
 - efficient algorithms for \overline{V} and C(x, y) for reasonable situations.
- Bioinformatics case: find intervals for C(x, y) and for V(x) and divide.



27. Case Study: Detecting Outliers

- In many application areas, it is important to detect outliers, i.e., unusual, abnormal values.
- In *medicine*, unusual values may indicate disease.
- In *geophysics*, abnormal values may indicate a mineral deposit (or an erroneous measurement result).
- In *structural integrity* testing, abnormal values may indicate faults in a structure.
- Traditional engineering approach: a new measurement result x is classified as an outlier if $x \notin [L, U]$, where

$$L \stackrel{\text{def}}{=} E - k_0 \cdot \sigma, \quad U \stackrel{\text{def}}{=} E + k_0 \cdot \sigma,$$

and $k_0 > 1$ is pre-selected.

• Comment: most frequently, $k_0 = 2, 3, \text{ or } 6.$



28. Outlier Detection Under Interval Uncertainty: A Problem

- In some practical situations, we only have intervals $\mathbf{x}_i = [\underline{x}_i, \overline{x}_i].$
- Different $x_i \in \mathbf{x}_i$ lead to different intervals [L, U].
- A possible outlier: outside some k_0 -sigma interval.
- Example: structural integrity not to miss a fault.
- A guaranteed outlier: outside all k_0 -sigma intervals.
- Example: before a surgery, we want to make sure that there is a micro-calcification.
- A value x is a possible outlier if $x \notin [\overline{L}, \underline{U}]$.
- A value x is a guaranteed outlier if $x \notin [\underline{L}, \overline{U}]$.
- Conclusion: to detect outliers, we must know the ranges of $L = E k_0 \cdot \sigma$ and $U = E + k_0 \cdot \sigma$.

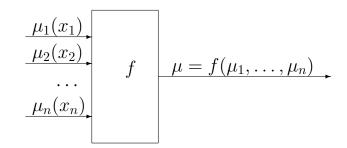


29. Outlier Detection Under Interval Uncertainty: A Solution

- We need: to detect outliers, we must compute the ranges of $L = E k_0 \cdot \sigma$ and $U = E + k_0 \cdot \sigma$.
- We know: how to compute the ranges **E** and $[\underline{\sigma}, \overline{\sigma}]$ for E and σ .
- Possibility: use interval computations to conclude that $L \in \mathbf{E} k_0 \cdot [\sigma, \overline{\sigma}]$ and $L \in \mathbf{E} + k_0 \cdot [\sigma, \overline{\sigma}]$.
- Problem: the resulting intervals for L and U are wider than the actual ranges.
- Reason: E and σ use the same inputs x_1, \ldots, x_n and are hence not independent from each other.
- Practical consequence: we miss some outliers.
- Desirable: compute exact ranges for L and U.
- Application: detecting outliers in gravity measurements.



30. Fuzzy Computations: A Problem



- Given: an algorithm $y = f(x_1, ..., x_n)$ and n fuzzy numbers $\mu_i(x_i)$.
- Compute: $\mu(y) = \max_{x_1,...,x_n:f(x_1,...,x_n)=y} \min(\mu_1(x_1),...,\mu_n(x_n)).$
- Motivation: y is a possible value of $Y \leftrightarrow \exists x_1, \ldots, x_n$ s.t. each x_i is a possible value of X_i and $f(x_1, \ldots, x_n) = y$.
- Details: "and" is min, \exists ("or") is max, hence $\mu(y) = \max_{x_1, \dots, x_n} \min(\mu_1(x_1), \dots, \mu_n(x_n), t(f(x_1, \dots, x_n) = y)),$ where t(true) = 1 and t(false) = 0.

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31. Fuzzy Computations: Reduction to Interval Computations

- Problem (reminder):
 - Given: an algorithm $y = f(x_1, ..., x_n)$ and n fuzzy numbers X_i described by membership functions $\mu_i(x_i)$.
 - Compute: $Y = f(X_1, ..., X_n)$, where Y is defined by Zadeh's extension principle:

$$\mu(y) = \max_{x_1,\dots,x_n:f(x_1,\dots,x_n)=y} \min(\mu_1(x_1),\dots,\mu_n(x_n)).$$

• *Idea*: represent each X_i by its α -cuts

$$X_i(\alpha) = \{x_i : \mu_i(x_i) \ge \alpha\}.$$

• Advantage: for continuous f, for every α , we have

$$Y(\alpha) = f(X_1(\alpha), \dots, X_n(\alpha)).$$

• Resulting algorithm: for $\alpha = 0, 0.1, 0.2, ..., 1$ apply interval computations techniques to compute $Y(\alpha)$.



32. Acknowledgments

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33. Proof of the Result about Chips

• Let us fix the optimal distributions for x_2, \ldots, x_n ; then,

$$Prob(D \le y_0) = \sum_{(x_1, ..., x_n) : D(x_1, ..., x_n) \le y_0} p_1(x_1) \cdot p_2(x_2) \cdot ...$$

- So, $\operatorname{Prob}(D \leq y_0) = \sum_{i=0}^{N} c_i \cdot q_i$, where $q_i \stackrel{\text{def}}{=} p_1(v_i)$.
- Restrictions: $q_i \ge 0$, $\sum_{i=0}^{N} q_i = 1$, and $\sum_{i=0}^{N} q_i \cdot v_i = E_1$.
- Thus, the worst-case distribution for x_1 is a solution to the following linear programming (LP) problem:

Minimize
$$\sum_{i=0}^{N} c_i \cdot q_i$$
 under the constraints $\sum_{i=0}^{N} q_i = 1$ and $\sum_{i=0}^{N} q_i \cdot v_i = E_1, q_i \ge 0, \quad i = 0, 1, 2, \dots, N.$



34. Proof of the Result about Chips (cont-d)

- Minimize: $\sum_{i=0}^{N} c_i \cdot q_i$ under the constraints $\sum_{i=0}^{N} q_i = 1$ and $\sum_{i=0}^{N} q_i \cdot v_i = E_1, q_i \ge 0, \quad i = 0, 1, 2, \dots, N.$
- Known: in LP with N+1 unknowns q_0, q_1, \ldots, q_N , $\geq N+1$ constraints are equalities.
- In our case: we have 2 equalities, so at least N-1 constraints $q_i \geq 0$ are equalities.
- Hence, no more than 2 values $q_i = p_1(v_i)$ are non-0.
- If corresponding v or v' are in $(\underline{x}_1, \overline{x}_1)$, then for $[v, v'] \subset \mathbf{x}_1$ we get the same y_0 in contradiction to non-degeneracy.
- Thus, the worst-case distribution is located at \underline{x}_1 and \overline{x}_1 .
- The condition that the mean of x_1 is E_1 leads to the desired formulas for p_1 and \overline{p}_1 .

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